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Fourfold anisotropic magnetoresistance of $L1_0$ FePt due to relaxation time anisotropy

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Experimental measurements show that the angular dependence of the anisotropic magnetoresistance (AMR) in L_{10} ordered FePt epitaxial films on the current orientation and magnetization direction is a superposition of the corresponding dependences of twofold and fourfold symmetries. The twofold AMR exhibits a strong dependence on the current orientation, whereas the fourfold term only depends on the magnetization direction in the crystal and is independent of the current orientation. First-principles calculations reveal that the fourfold AMR arises from the relaxation time anisotropy due to the variation of the density of states near the Fermi energy under rotation of the magnetization. This relaxation time anisotropy is a universal property in ferromagnetic metals and determines other anisotropic physical properties that are observable in experiment.

Introduction.—The fundamental physics of spintronics is the interplay of magnetization in magnetic materials and electrical currents [1]. The electrical resistance of a magnetic device typically depends on the magnetization configuration, resulting in a variety of intriguing magnetoresistance (MR) phenomena, such as spin-Hall MR [2], Rashba-Edelstein MR [3], spin-orbital MR [4], anomalous Hall MR [5], and Hanle MR [6], which are effectively applied in probing a magnetic field or magnetization. As a basic MR effect in ferromagnetic metals (FMs) and alloys, AMR describes the dependence of electrical resistivity on the magnetization direction [7–12].

AMR and its angular dependence on the current orientation and magnetization direction are attributed to the interaction among the crystal field, exchange field and spin-orbit coupling (SOC) [13–15]. Most early studies were carried out on polycrystalline samples, in which the symmetry constraint only allowed a twofold term that scaled as $\cos^2 \varphi_M$, where φ_M is the angle between the magnetization and current [16]. Twofold AMR has multiple microscopic mechanisms including s-d scattering [14, 17], the intrinsic mechanism from band crossings [18] and band splitting due to lattice distortion [19]. Fourfold AMR has been experimentally observed in Fe, Co and Ni epitaxial films [20–24], (Ga,Mn)As [25, 26], manganites [27, 28], Fe₃O₄ [29, 30], Co₂MnSi [31] and antiferromagnetic $EuTiO_3$ [32]. It exists in pseudoepitaxial Fe_4N films [19, 33, 34] at low temperatures and vanishes at elevated temperatures. The latter was ascribed to the tetragonal lattice distortion in Fe_4N [19], but this interpretation is not applicable to cubic Ni [21]. Recently, the fourth-order perturbation of SOC was proposed to be the mechanism in cubic crystals [35]. So far, fourfold AMR is still poorly understood.

 $L1_0$ Fe_{0.5}(Pd_{1-x}Pt_x)_{0.5} is an ordered ferromagnetic alloy in which both the degree of chemical ordering and SOC strength are tunable and is therefore an ideal material to investigate the microscopic mechanisms underlying AMR. Systematic measurement of the resistivity of FePt epitaxial films combined with first-principles calculations allows us to gain a thorough understanding of the observed angular dependence of AMR. Using the currentorientation independence as the criterion, we discover that the fourfold AMR arises from the variation in the density of states near the Fermi surface, which results in the relaxation time anisotropy under rotation of the magnetization with respect to the crystallographic axes.

Measured AMR of FePt. — A single-crystal FePt (001) film is epitaxially grown on an MgO (001) substrate and patterned into arcuate Hall bars so that the current direction is continuously variable, as schematized in Fig. 1(a). The degree of chemical ordering S is controlled by the substrate temperature during fabrication and the postannealing temperature [36]. S = 1 for a fully ordered structure, and S = 0 for a completely disordered alloy.

The magnetization within the (001) plane is rotated to measure the longitudinal resistivity ρ_{xx} of FePt with S = 0.82 for currents along [100] and [110], as shown in Fig. 1(b) and (c), respectively. The measured data are effectively fitted using the following superposition of the twofold and fourfold AMR terms:

$$\rho_{xx}(\varphi_M) = \rho_0 + \Delta \rho_2 \cos 2(\varphi_M + \varphi_2) + \Delta \rho_4 \cos 4(\varphi_M + \varphi_4), \tag{1}$$

where φ_M represents the angle between the magnetization and sensing current defined in Fig. 1(a) and ρ_0 is the average resistivity independent of φ_M . The last two terms in Eq. (1) correspond to the twofold and fourfold variations in resistivity, with phases of φ_2 and φ_4 , respectively. In Fig. 1(d) and (e), the fitted $\Delta \rho_2$ and $\Delta \rho_4$ are plotted as a function of the current direction α_J , which is defined by the angle between the current direction and the crystal axis [100] [see Fig. 1(a)]. $\Delta \rho_2$ is highly sensitive to the sensing current direction and is small and negative at $\mathbf{J} \parallel [100]$ and becomes large and positive at $\mathbf{J} \parallel [110]$. By contrast, the fourfold term $\Delta \rho_4$ has a nearly



FIG. 1. (a) Schematic of AMR measurement. The measured resistivity ρ_{xx} of the L1₀ FePt film with S = 0.82 at point A (**J**||[100]) and point B (**J**||[110]) is plotted in (b) and (c), respectively, as a function of the magnetization direction (φ_M) with respect to the sensing current. The solid lines in (b) and (c) correspond to fits using Eq. (1). The fitted parameters $\Delta \rho_{2(4)}$ and $\varphi_{2(4)}$ are shown in (d), (e) and (f) as a function of the current orientation (α_{J}) with respect to the crystalline axis [100]. The measurement is carried out at a low temperature of T = 10 K.

constant magnitude that varies by less than 10% over the range of $0 \leq \alpha_{\mathbf{J}} \leq 90^{\circ}$. The associated phase φ_4 in the fourfold term is always equal to the current orientation $\alpha_{\mathbf{J}}$, as shown in Fig. 1(f). This result suggests that fourfold AMR is independent of the current orientation and depends only on the magnetization direction with respect to the crystallographic axes. Unlike φ_4 , the phase φ_2 in the twofold term exhibits nonmonotonic variation between -45° and 45° suggesting competition of multiple components [36].

Figure 2 shows $\Delta \rho_2$ and $\Delta \rho_4$ that are extracted using Eq. (1) from experimental data [36] as a function of the temperature for samples with various degrees of chemical order. Here, we focus on two sensing current directions along high-symmetry axes, [100] and [110]. For $\mathbf{J} \| [100], \Delta \rho_2$ is negative at large S [see the orange and blue symbols in Fig. 2(a)]. At intermediate S, the twofold AMR exhibits a transition from negative at low temperatures to positive at room temperature and above. In the completely disordered sample, $\Delta \rho_2$ is always positive and nearly invariant with increasing temperature. The temperature dependence of $\Delta \rho_2$ is strikingly different for $\mathbf{J} \parallel [110]$ in Fig. 2(c), where it decreases with increasing temperature for all samples. Comparing Fig. 2(b) and (d), we find that the fourfold AMR has the same temperature dependence for $\mathbf{J} \parallel [100]$ and $\mathbf{J} \parallel [110]$. With increas-



FIG. 2. Fitted AMR parameters $\Delta \rho_2$ and $\Delta \rho_4$ as a function of temperature for samples with different degrees of chemical order. The measurement is carried out under a fixed current orientation that is along [100] in (a) and (b) and along [110] in (c) and (d).

ing temperature, $\Delta \rho_4$ increases for S = 1 and decreases for smaller S. The fourfold AMR vanishes in the sample with S = 0.

Twofold AMR.—It is difficult to conclusively determine the AMR dependence on the degree of chemical ordering and temperature from Fig. 2 because both factors influence the AMR simultaneously. To obtain deeper insight into this dependence, we replot the measured $\Delta \rho_2$ of all the samples as a function of the corresponding average resistivity ρ_0 for $\mathbf{J} \parallel [100]$ in Fig. 3(a). A common trend in the experimental data is thus revealed: $\Delta \rho_2$ is negative at low resistivities and becomes positive at large ρ_0 . For the fully disordered alloy with S = 0, $\Delta \rho_2$ is a positive constant that is independent of ρ_0 .

We perform a first-principles transport calculation for fully-ordered $L1_0$ FePt with S = 1, where temperatureinduced lattice disorder is introduced to account for the finite resistivity [36, 44]. By increasing the temperature, we qualitatively reproduce the resistivity dependence of twofold AMR, as shown in the inset of Fig. 3(a), and the difference at small ρ_0 is attributed to the large perpendicular anisotropy of highly ordered FePt [36]. The negative $\Delta \rho_2$ at low ρ_0 and positive value at large ρ_0 can be understood by analyzing the band structure of $L1_0$ FePt. Figure 3(b) shows the energy bands near the Fermi energy E_F along the high-symmetry direction $\langle 100 \rangle$ for parallel $(\Gamma M')$ or perpendicular (ΓM) magnetizations. In the low disorder regime, the twofold AMR is nearly independent of the scattering rate or relaxation time, suggesting an intrinsic contribution due to band (anti)crossing [18]. These special band crossings are a consequence of symmetry at a given **M**, whereas rotating **M** breaks the symmetry and lifts the band degeneracy. As the energy bands



FIG. 3. Fitted $\Delta \rho_2$ as a function of the average resistivity ρ_0 for current along [100] (a) and [110] (c). Inset of (a): Calculated $\Delta \rho_2$ as a function of ρ_0 for fully-ordered FePt with thermal lattice disorder. Calculated band structure with SOC along $\langle 100 \rangle$ (b) and along $\langle 110 \rangle$ (d). The magnetization is parallel to $\Gamma M'$ ($\Gamma X'$) and perpendicular to ΓM (ΓX). The colors of the energy bands indicate the spin projection along the quantization axis. The circles with different sizes represent the *sp* components of the Bloch states.

near E_F have the characteristics of sp-d hybridization, we focus on the itinerant sp bands (marked by empty circles) that have a stronger influence on transport than the more localized d bands. Rotating **M** from [100] to [010] results in the disappearance of a crossing of sp bands along [100] (Γ M') (marked by purple ellipses) and hence slightly increases the resistivity, corresponding to a negative $\Delta \rho_2$. As we increase ρ_0 by increasing the temperature or decreasing S, the contribution of disorder scattering to the AMR becomes more important. Most of the d bands near E_F have the minority-spin component [45], and therefore, sp- d_{\downarrow} scattering leads to a positive $\Delta \rho_2$ [16].

For $\mathbf{J} \parallel [110]$, an arbitrary ρ_0 corresponds to different $\Delta \rho_2$ depending on the details of the degree of chemical order; see Fig. 3(c). This behavior implies that the AMR mainly arises from extrinsic disorder scattering, in agreement with the calculated band structure. As shown in Fig. 3(d), the energy bands along [110] near E_F are unchanged for $\mathbf{M} \parallel [110]$ ($\Gamma X'$) or $\mathbf{M} \parallel [1\overline{10}]$ (ΓX) and hence make no intrinsic contribution to the AMR. When disorder scattering becomes stronger with increasing temperature, the resulting band smearing enables the energy bands farther away from E_F to affect electron transport. The band crossings along $\Gamma X'$ become anticrossing gaps along ΓX (marked by purple ellipses), corresponding to a negative $\Delta \rho_2$ from the intrinsic mechanism. Therefore, the experimentally measured $\Delta \rho_2$ for all S decreases with increasing temperature.

Fourfold AMR.—The experimental fourfold AMR $\Delta \rho_4$ is plotted in Fig. 4(a) as a function of the measured

average resistivity ρ_0 . The data extracted from different sensing current directions overlap with each other. With increasing ρ_0 , $\Delta \rho_4$ of the highly ordered samples increases and it decreases for samples with smaller S. The strong dependence of $\Delta \rho_4$ on the ordering degree and temperature indicates that the physical mechanism for fourfold AMR is related to scattering. Moreover, the measurements with various sample thicknesses confirm that fourfold AMR is not a surface effect but exists in bulk $L1_0$ FePt [36]. A first-principles transport calculation of fully-ordered $L1_0$ FePt also reproduces the nonmonotonic ρ_0 -dependent fourfold AMR: with increasing temperature-induced thermal lattice disorder, the calculated $\Delta \rho_4$ increases to a maximum and then decreases, as shown in Fig. 4(b). In addition, the calculated resistivity also exhibits maxima and minima at $\mathbf{M} || \langle 100 \rangle$ and $\mathbf{M} \| \langle 110 \rangle$, respectively [36], in agreement with experiment. The calculated $\Delta \rho_4$ is much larger than the experimental values and this discrepancy may be attributed to the neglected spin fluctuation and chemical disorder in the calculation.

Fourfold AMR in Fe₄N is attributed to energy-band hybridization resulting from the interplay of SOC and tetragonal distortion [19]. The predictions of this theory, however, contradict both our experimental observations and calculations for $\Delta \rho_4$. Experimentally, the structural L1₀-A₁ phase transition of FePt occurs near 1300°C [46], below which the tetragonal structure of FePt films is sustained. However, the measured $\Delta \rho_4$ becomes very small near 400 K far below the phase transition temperature, as seen in Fig. 2(b) and (d), especially for small *S*. In



FIG. 4. (a) Fitted $\Delta \rho_4$ from experimentally measured resistivity. (b) Calculated $\Delta \rho_4$ as a function of the total resistivity for fully-ordered FePt. (c) Calculated DOS of FePt as a function of the magnetization direction rotated within the (001) plane. The black circles and red squares are calculated at E_F and $E_F - 0.0185$ eV, respectively. The Brillouin zone is sampled by ~ 2400³ k-points for convergence. (d) The difference in the finite-temperature DOS for $\mathbf{M} \parallel [100]$ and $\mathbf{M} \parallel [110]$ calculated using Eq. (3).

our calculation, the tetragonal structure of L1₀ FePt is not affected by temperature, whereas the calculated $\Delta \rho_4$ exhibits a nonmonotonic dependence.

Under rotation of the magnetization, SOC mediates the electronic states in the crystal field, leading to a variation in the density of states (DOS) at the Fermi energy. Using a hybrid Wannier-Bloch representation [47], we calculate the DOS of fully-ordered L1₀ FePt and two typical cases at E_F and $E_F - 0.0185$ eV are plotted in Fig. 4(c), both of which show fourfold symmetry and the maxima (minima) at $\mathbf{M} || \langle 100 \rangle (\mathbf{M} || \langle 110 \rangle)$. The electronic scattering rate at the Fermi level is inversely proportional to the relaxation time and determined by the Fermi golden rule [48],

$$\frac{1}{\tau} \propto \frac{2\pi}{\hbar} |\langle f|V|i\rangle|^2 D_f D_i.$$
(2)

Here, we only consider the dominant elastic scattering contribution due to the scattering potential V. In Eq. (2), $|i\rangle$ and $|f\rangle$ are the initial and final states, respectively. D_i and D_f represent the densities of these states at the Fermi energy. For $\mathbf{M} || \langle 100 \rangle$, the increase in the DOS enhances the scattering probability of Bloch states and thus reduces the relaxation time. This picture explains why the fourfold AMR only depends on the magnetization direction with respect to the crystallographic axes and is invariant for different sensing current directions.

With increasing chemical and lattice disorder, energyband smearing causes states away from E_F to be incorporated into the DOS at the Fermi energy. By introducing a Fermi-Dirac distribution function at finite temperature f(E,T), we calculate the DOS at E_F as

$$D(E_F,T) = \int_{-\infty}^{\infty} dE \, D(E) \left[-\frac{\partial f(E,T)}{\partial E} \right].$$
(3)

The difference of calculated DOS between $\mathbf{M} \| \langle 100 \rangle$ and \mathbf{M} (110) is plotted in Fig. 4(d). The anisotropic DOS also exhibits a nonmonotonic dependence on temperature that is consistent with that of the fourfold AMR. This nonmonotonic behavior is attributed to the fact that the DOS has a larger anisotropy at $E_F + \epsilon$ than at E_F . Thus, increasing the temperature enables the energy $E_F + \epsilon$ to contribute to transport and enhances the fourfold AMR. An enough high temperature involves a very large energy range and eventually averages out the anisotropy in the DOS. Note that the calculated $\Delta \rho_4$ in Fig. 4(b) and anisotropic DOS in Fig. 4(d) decrease more slowly with the temperature than the experimental $\Delta \rho_4$ in Fig. 4(a). This result is obtained because chemical disorder and spin wave excitations, which are not included in the calculation, strongly suppress the fourfold AMR in reality by breaking local symmetry.

With SOC that couples spin and real space, the particular magnetization orientation affects the electronic structure and thus modulates the DOS near Fermi surface. Such a modulation follows the crystal symmetry



FIG. 5. (a) Measured $\Delta \rho_4$ of L1₀ ordered Fe_{0.5}(Pd_{1-x}Pt_x)_{0.5} 20-nm-thick films as a function of Pt concentration x at 10 K. The inset shows the measured ρ_{xx} . (b) Calculated $\Delta \rho_4$ of FePt as a function of scaled SOC strength. The black dashed line indicates the SOC strength of FePd. The dotted line illustrates quadratic dependence.

and hence leads to fourfold AMR in any metallic ferromagnets with fourfold symmetry. By carefully studying the literature, we have found that the measured fourfold AMR in Co [21], Ni [24] and Fe₄N [33] are independent of current direction in agreement with our findings. It indicates that the proposed microscopic mechanism for the fourfold AMR is universal for ferromagnetic metals.

In addition to resistivity, relaxation time is important for Gilbert damping that characterizes dynamical magnetization dissipation [49]. At low temperature, Kamberský's breathing Fermi surface model [50] explicitly shows the proportionality of Gilbert damping and relaxation time, while Gilbert damping at high temperature is inversely proportional to relaxation time due to the dominant interband scattering [51]. This nonmonotonic relationshop has been demonstrated by first-principles calculations [52]. Thus the relaxation time anisotropy due to the modulation of DOS shall lead to anisotropic Gilbert damping [53], which was recently observed in single-crystal ferromagnets but has not yet been understood [54, 55].

The isoelectronic properties of Pt and Pd enable the SOC strength to be mediated by changing the Pt/Pd atomic concentration, whereas other parameters, such as the lattice constant, saturation magnetization, and Curie temperature, remain almost the same [56, 57]. We measure the resistivity and AMR in (001) L1₀ Fe_{0.5}(Pd_{1-x}Pt_x)_{0.5} for different Pt concentrations x. The sheet resistivity exhibits a maximum near x = 0.5 and thus obeys Nordheim's rule [58], whereas the magnitude of $\Delta \rho_4$ increases with x and is nearly independent of the current orientation as shown in Fig. 5(a). The enhanced $\Delta \rho_4$ with increasing SOC strength is reproduced by first-principles transport calculation by artificially reducing SOC of FePt; see Fig. 5(b). At small SOC strength, $\Delta \rho_4$ exhibits a quadratic dependence on SOC.

Summary.— We studied the AMR of (001) $L1_0$ FePt epitaxial films by systematically varying the degree of chemical order and temperature and identified the underlying microscopic mechanisms of AMR. Twofold AMR arises from the competition between the intrinsic mecha-

nism due to magnetization-orientation-dependent band crossings and the extrinsic scattering mechanism that results from thermal and chemical disorder scattering. Fourfold AMR is attributed to the variation in the DOS and hence in the relaxation time at the Fermi surface that is induced by rotating the magnetization. Currentorientation independence is the main criterion used to identify this mechanism. The relaxation time anisotropy is universal for other FMs with proper symmetry and is a possible mechanism for the anisotropic Gilbert damping observed in recent experiments.

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